

UNISONIC TECHNOLOGIES CO., LTD

7N50-MTQ Preliminary Power MOSFET

7.0A, 500V N-CHANNEL POWER MOSFET

■ DESCRIPTION

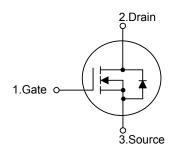
The UTC **7N50-MTQ** is an N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology allows a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

The UTC 7N50-MTQ is generally applied in high efficiency switch mode power supplies.



^{*} $R_{DS(ON)}$ < 0.87 Ω @ V_{GS} = 10 V, I_{D} = 3.5 A

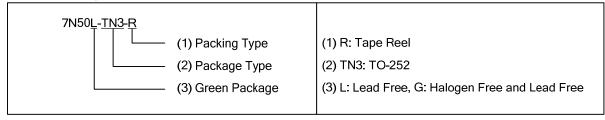
SYMBOL



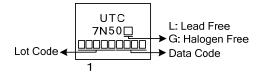
ORDERING INFORMATION

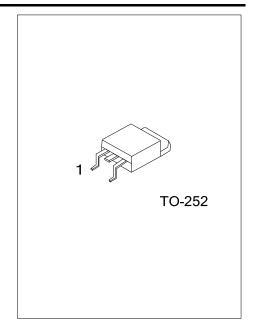
Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
7N50L-TN3-R	7N50G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



MARKING





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^{*} High Switching Speed

■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		$V_{ extsf{DSS}}$	500	V	
Gate-Source Voltage		V_{GSS}	±30	V	
Drain Current	Continuous	T _C =25°C	I _D	7	Α
	Pulsed (Note 2)		I _{DM}	28	Α
Avalanche Energy	Single Pulsed (Note 3)		E _{AS}	270	mJ
Power Dissipation (T _C =25°C)		Б	39	W	
Derate above 25°C		P_D	3.2	W/°C	
Junction Temperature		T_J	+150	°C	
Storage Temperature		T _{STG}	-55~+150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L = 10mH, I_{AS} = 7A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 4. $I_{SD} \le 7A$, di/dt $\le 200A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$

■ THERMAL RESISTANCES CHARACTERISTICS

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	$\theta_{ m JC}$	3.2	°C/W	

■ ELECTRICAL CHARACTERISTICS

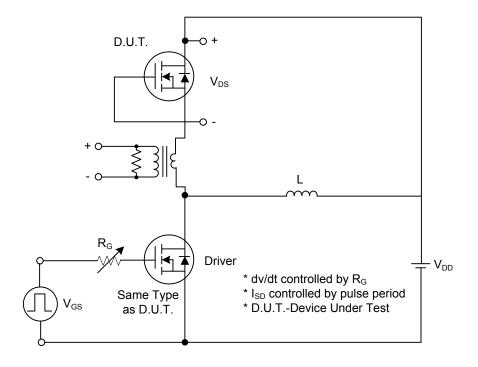
PARAMETER		SYMBOL	TEST CONDITIONS		TYP	MAX	UNIT	
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage		BV _{DSS}	$I_D=250\mu A, V_{GS}=0V$	500			V	
Breakdown Voltage Temperature Coefficient		$\triangle BV_{DSS}/\triangle T_{J}$	Reference to 25°C, I _D =250µA		0.5		V/°C	
Drain-Source Leakage Current		I_{DSS}	V _{DS} =500V, V _{GS} =0V			10	μΑ	
Gate- Source Leakage Current	Forward	lass	V _{GS} =+30V, V _{DS} =0V			+100	nA	
	Reverse	I_{GSS}	V _{GS} =-30V, V _{DS} =0V			-100	nA	
ON CHARACTERISTICS								
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_D=250\mu A$	2.0		4.0	V	
Static Drain-Source On-State Resistance		R _{DS(ON)}	V_{GS} =10V, I_D =3.5A			0.87	Ω	
DYNAMIC PARAMETERS								
Input Capacitance		C_{ISS}			750		pF	
Output Capacitance		Coss	V _{GS} =0V, V _{DS} =25V, f=1.0MHz		130		pF	
Reverse Transfer Capacitance		C_{RSS}			16		pF	
SWITCHING PARAMETERS								
Turn-ON Delay Time		$t_{D(ON)}$			55		ns	
Rise Time		t_R	V_{DS} =30V, I_{D} =0.5A, R_{G} =25 Ω		43		ns	
Turn-OFF Delay Time		t _{D(OFF)}	(Note 1, 2)		210		ns	
Fall-Time		t_{F}			40		ns	
Total Gate Charge at 10V		$Q_{G(TOT)}$	\\ -10\\ \\ -50\\ -1.2A		90		nC	
Gate to Source Charge		Q_GS	V _{GS} =10V, V _{DS} =50V, I _D =1.3A (Note 1, 2)		6.5		nC	
Gate to Drain Charge		Q_GD	(14016 1, 2)		7.5		nC	
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current		Is				7	Α	
Maximum Body-Diode Pulsed Co	Maximum Body-Diode Pulsed Current					28	Α	
Drain-Source Diode Forward Voltage		V_{SD}	I _{SD} =7A, V _{GS} =0V			1.4	V	

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

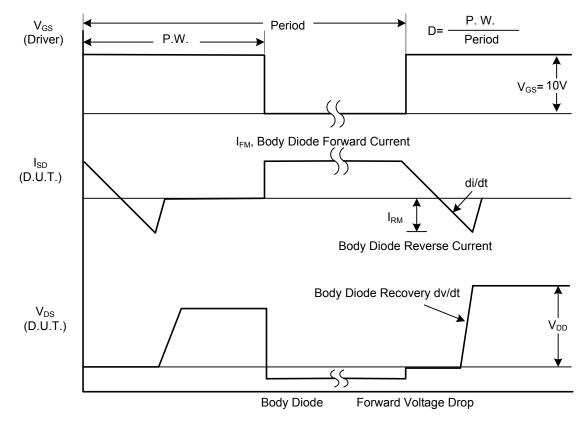
2. Essentially Independent of Operating Temperature Typical Characteristics



■ TEST CIRCUITS AND WAVEFORMS

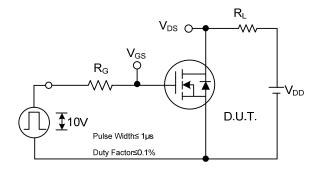


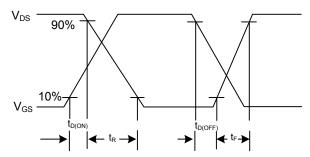
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

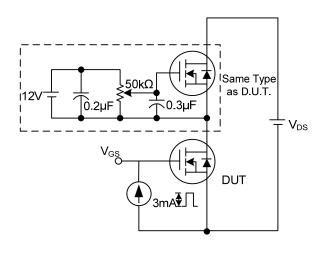
■ TEST CIRCUITS AND WAVEFORMS (Cont.)

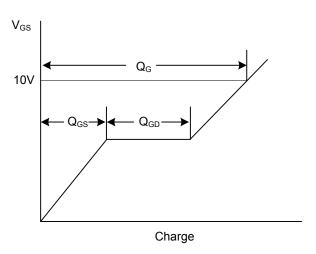




Switching Test Circuit

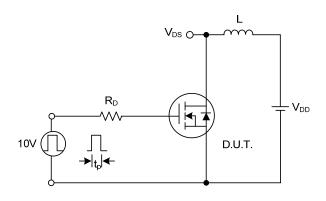
Switching Waveforms

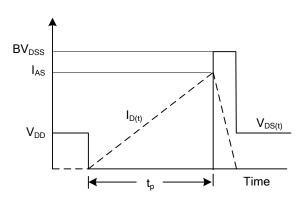




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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